

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

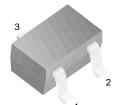
Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.



FJX2907A

General Purpose Transistor



SOT-323

1. Base 2. Emitter 3. Collector

PNP Epitaxial Silicon Transistor

Absolute Maximum Ratings T_a=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V_{CBO}	Collector-Base Voltage	-60	V
V _{CES}	Collector-Emitter Voltage	-60	V
V_{EBO}	Emitter-Base Voltage	-5	V
I _C	Collector Current	-600	mA
P _C	Collector Power Dissipation	350	mW
T _{STG}	Storage Temperature	150	°C

Electrical Characteristics T_a =25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
BV _{CBO}	Collector-Base Breakdown Voltage	I _C = -10μA, I _E =0	-60		V
BV _{CEO}	* Collector-Emitter Breakdown Voltage	I _C = -10mA, I _B =0	-60		V
BV _{EBO}	Emitter-Base Breakdown Voltage	I _E = -10μA, I _C =0	-5		V
I _{CBO}	Collector Cut-off Current	V _{CB} = -50V, I _E =0		-0.01	μΑ
h _{FE}	DC Current Gain	V_{CE} = -10V, I_{E} = -0.1mA V_{CE} = -10V, I_{C} = -1.0mA V_{CE} = -10V, I_{C} = -10mA V_{CE} = -10V, I_{C} = -150mA V_{CE} = -10V, I_{C} = -500mA	75 100 100 100 50	300	
V _{CE} (sat)	* Collector-Emitter Saturation Voltage	I _C = -150mA, I _B = -15mA I _C = -500mA, I _B = -50mA		-0.4 -1.6	V V
V _{BE} (sat)	* Base-Emitter Saturation Voltage	I _C = -150mA, I _B = -15mA I _C = -500mA, I _B = -50mA		-1.3 -2.6	V V
f _T	Current Gain Bandwidth Product	I_{C} = -50mA, V_{CE} = -20V, f=100MHz	200		MHz
C _{ob}	Output Capacitance	V _{CB} = -10V, I _E =0 f=1.0MHz		8	pF
t _{ON}	Turn On Time	V_{CC} = -30V, I_{C} = -150mA I_{B1} = -15mA		45	ns
t _{OFF}	Turn Off Time	V_{CC} = -6V, I_{C} = -150mA I_{B1} = I_{B2} =15mA		100	ns

* Pulse Test: PW≤300μs, Duty Cycle≤2%



Typical Characteristics

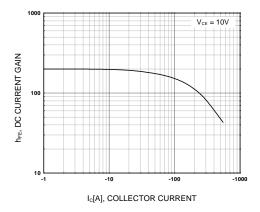


Figure 1. DC current Gain

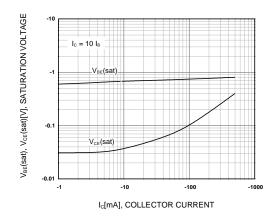


Figure 2. Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage

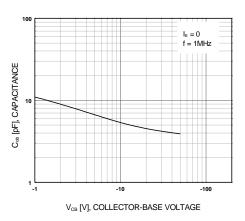


Figure 3. Output Capacitance

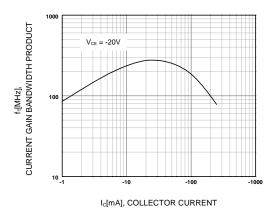
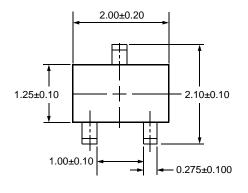
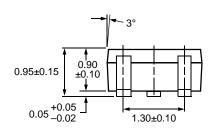


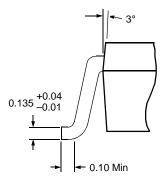
Figure 4. Current Gain Bandwidth Product

Package Demensions

SOT-323







Dimensions in Millimeters

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Datasheet Identification	Product Status	Definition
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